


<b>Search Notes</b> 	<b>Application/Control No.</b> 10560783	<b>Applicant(s)/Patent Under Reexamination</b> EBIKO, MASAHIRO
	<b>Examiner</b> Steven D Maki	<b>Art Unit</b> 1791

SEARCHED			
Class	Subclass	Date	Examiner
152	209.18, 209.27, 209.28, Dig. 3	3-26-08	/SM/
	updated above	10-10-08	/SM/
D12	557-567	10-11-08	/SM/

SEARCH NOTES		
Search Notes	Date	Examiner
directional and groove cross section digests kept in examiner's office	3-26-08	/SM/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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